

Fig. S1 Photocurrent versus incident wavelength curves for devices of different thicknesses at the same light intensity. (a) 13 nm Ga₂O₃-based device. (b) 75 nm Ga₂O₃-based device. (c) 160 nm Ga₂O₃-based device.

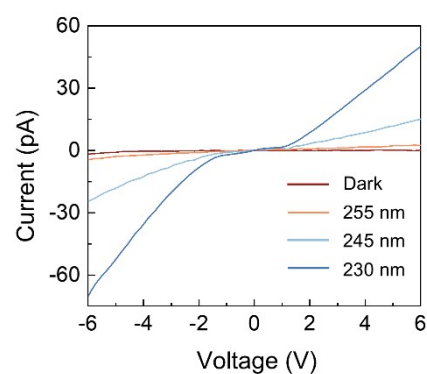


Fig. S2 I-V curves of 13 nm thick Ga₂O₃ under illumination at different wavelengths.